

<b>Notice of References Cited</b>	Application/Control No. 10/774,944	Applicant(s)/Patent Under Reexamination LIN, PAI YUNG	
	Examiner Shay L Balsis	Art Unit 1744	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,813,801	11-2004	Tanaka et al.	15/229.3
*	B	US-2004/0016074	01-2004	Tanaka, Yoshinori	15/228
*	C	US-823,725	06-1906	Hayden, H.	15/114
*	D	US-1,922,450	08-1933	RAY O'BRIEN GEORGE	15/220.4
*	E	US-4,116,205	09-1978	Owen et al.	132/313
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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